

NC7SZ00**TinyLogic™ UHS 2-Input NAND Gate****General Description**

The NC7SZ00 is a single 2-Input NAND Gate from Fairchild's Ultra High Speed Series of TinyLogic™. The device is fabricated with advanced CMOS technology to achieve ultra high speed with high output drive while maintaining low static power dissipation over a broad V_{CC} operating range. The device is specified to operate over the 1.8V to 5.5V V_{CC} operating range. The inputs and output are high impedance when V_{CC} is 0V. Inputs tolerate voltages up to 6V independent of V_{CC} operating voltage.

Features

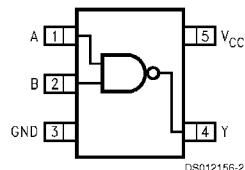
- Space saving SOT23 or SC70 5-lead surface mount package
- Ultra High Speed; T_{PD} 2.4 ns typ into 50 pF at 5V V_{CC}
- High Output Drive; ± 24 mA at 3V V_{CC}
- Broad V_{CC} Operating Range; 1.8V–5.5V
- Matches the performance of LCX when operated at 3.3V V_{CC}
- Power down high impedance inputs/output
- Overvoltage tolerant inputs facilitate 5V to 3V translation
- Patented noise/EMI reduction circuitry implemented

Ordering Code:

Product Code	Package	Package Drawing	Package Top Mark	Supplied As
NC7SZ00M5	SOT23-5	MA05B	7Z00	250 Units on Tape and Reel
NC7SZ00M5X	SOT23-5	MA05B	7Z00	3k Units on Tape and Reel
NC7SZ00P5	SC70-5	MAA05A	Z00	250 Units on Tape and Reel
NC7SZ00P5X	SC70-5	MAA05A	Z00	3k Units on Tape and Reel

Logic Symbol**Connection Diagram**

Pin Assignment for 5-lead Packages



(Top View)

Pin Descriptions

Pin Names	Description
A, B	Inputs
Y	Output

Function Table

$$Y = \overline{AB}$$

Inputs		Output
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

H = HIGH Logic Level
L = LOW Logic Level

Absolute Maximum Ratings (Note 1)

Supply Voltage (V_{CC})	-0.5V to +6V	Negative Source Current (NIT)	-500 mA
DC Input Voltage (V_{IN})	-0.5V to +6V	Positive Source Voltage (PVT)	+8V
DC Output Voltage (V_{OUT})	-0.5V to +6V		
DC Input Diode Current (I_{IK})			
@ $V_{IN} < -0.5V$	-50 mA	Supply Voltage Operating (V_{CC})	1.8V to 5.5V
@ $V_{IN} > 6V$	+20 mA	Supply Voltage Data Retention (V_{CC})	1.5V to 5.5V
DC Output Diode Current (I_{OK})		Input Voltage (V_{IN})	0V to 5.5V
@ $V_{OUT} < -0.5V$	-50 mA	Output Voltage (V_{OUT})	0V to V_{CC}
@ $V_{OUT} > 6V, V_{CC} = GND$	+20 mA	Operating Temperature (T_A)	-40°C to +85°C
DC Output Current (I_{OUT})	± 50 mA	Input Rise and Fall Time (t_r, t_f)	
DC V_{CC}/GND Current (I_{CC}/I_{GND})	± 50 mA	$V_{CC} @ 1.8V, 2.5V \pm 0.2V$	0 ns/V to 20 ns/V
Storage Temperature (T_{STG})	-65°C to +150°C	$V_{CC} @ 3.3V \pm 0.3V$	0 ns/V to 10 ns/V
Junction Temperature under Bias (T_J)	150°C	$V_{CC} @ 5.0V \pm 0.5V$	0 ns/V to 5 ns/V
Junction Lead Temperature (T_L); (Soldering, 10 seconds)	260°C	Thermal Resistance (θ_{JA})	
Power Dissipation (P_D) @ +85°C		SOT23-5	300°C/W
SOT23-5	200 mW	SC70-5	425°C/W
SC70-5	150 mW		
ESD Tolerance (Human Body Model)			
MIL-STD-883D Method 3015.7	1000V		
DC Latchup Tolerance (JEDEC Method 17)			

Recommended Operating Conditions

Note 1: Absolute maximum ratings are DC values beyond which the device may be damaged or have its useful life impaired. The datasheet specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation outside datasheet specifications.

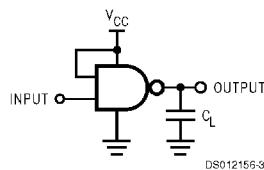
DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	NC7SZ00			Units	Conditions		
			$T_A = +25^\circ C$						
			Min	Typ	Max				
V_{IH}	High Level Input Voltage	1.8 2.3–5.5	0.75 V_{CC} 0.70 V_{CC}		0.75 V_{CC} 0.70 V_{CC}	V			
V_{IL}	Low Level Input Voltage	1.8 2.3–5.5		0.25 V_{CC} 0.30 V_{CC}		V			
V_{OH}	High Level Output Voltage	1.8	1.7	1.8	1.7	V	$V_{IN} = V_{IL}$		
		2.3	2.2	2.3	2.2				
		3.0	2.9	3.0	2.9				
		4.5	4.4	4.5	4.4				
		2.3	1.9	2.15	1.9	V	$I_{OH} = -100 \mu A$ $I_{OH} = -8 mA$ $I_{OH} = -16 mA$ $I_{OH} = -24 mA$ $I_{OH} = -32 mA$		
		3.0	2.4	2.80	2.4				
		3.0	2.3	2.68	2.3				
		4.5	3.8	4.20	3.8				
V_{OL}	Low Level Output Voltage	1.8	0.0	0.1	0.1	V	$V_{IN} = V_{IH}$		
		2.3	0.0	0.1	0.1				
		3.0	0.0	0.1	0.1				
		4.5	0.0	0.1	0.1				
		2.3	0.10	0.3	0.3	V	$I_{OL} = 8 mA$ $I_{OL} = 16 mA$ $I_{OL} = 24 mA$ $I_{OL} = 32 mA$		
		3.0	0.15	0.4	0.4				
		3.0	0.22	0.55	0.55				
		4.5	0.22	0.55	0.55				
I_{IN}	Input Leakage Current	0.5–5.5	± 1	± 10	μA	$V_{IN} = 5.5V, GND$			
I_{OFF}	Power Off Leakage Current	0.0	1	10	μA	V_{IN} or $V_{OUT} = 5.5V$			
I_{CC}	Quiescent Supply Current	1.8–5.5		2.0	μA	$V_{IN} = 5.5V, GND$			

AC Electrical Characteristics

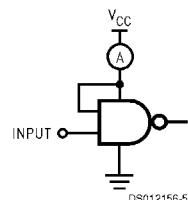
Symbol	Parameter	V _{CC} (V)	NC7SZ00			NC7SZ00			Units	Conditions	Fig. No.			
			T _A = +25°C			T _A = -40°C to +85°C								
			Min	Typ	Max	Min	Max							
t _{PLH} , t _{PHL}	Propagation Delay	1.8	2.0	4.5	9.5	2.0	10.0	ns	C _L = 15 pF, R _L = 1 MΩ	Figures 1, 3				
		2.5 ±0.2	0.8	3.0	6.5	0.8	7.0							
		3.3 ±0.3	0.5	2.4	4.5	0.5	4.7							
		5.0 ±0.5	0.5	2.0	3.9	0.5	4.1							
t _{PLH} , t _{PHL}	Propagation Delay	3.3 ±0.3	1.5	2.9	5.0	1.5	5.2	ns	C _L = 50 pF, R _L = 500Ω	Figures 1, 3				
		5.0 ±0.5	0.8	2.4	4.3	0.8	4.5							
C _{IN}	Input Capacitance	0	4					pF						
C _{PD}	Power Dissipation Capacitance	3.3	24					pF	(Note 2)	Figure 2				
Note 2: C _{PD} is defined as the value of the internal equivalent capacitance which is derived from dynamic operating current consumption (I _{CCD}) at no output loading and operating at 50% duty cycle. (See Figure 2.) C _{PD} is related to I _{CCD} dynamic operating current by the expression: I _{CCD} = (C _{PD})(V _{CC})(f _{IN}) + (I _{CCS} static).														

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C_L includes load and stray capacitance
Input PRR = 1.0 MHz; t_w = 500 ns

FIGURE 1. AC Test Circuit



Input = AC Waveform; t_r = t_f = 1.8 ns;
PRR = 10 MHz; Duty Cycle = 50%

FIGURE 2. I_{CCD} Test Circuit

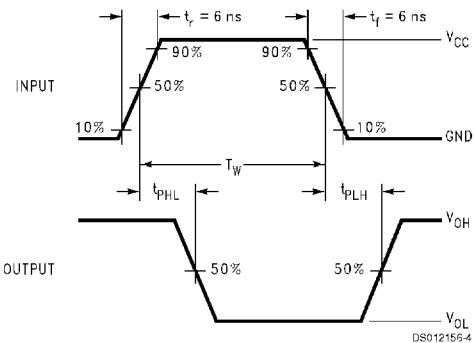
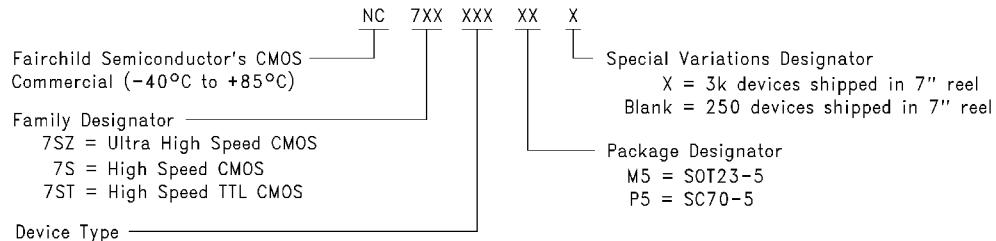


FIGURE 3. AC Waveforms

Ordering Information

The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:



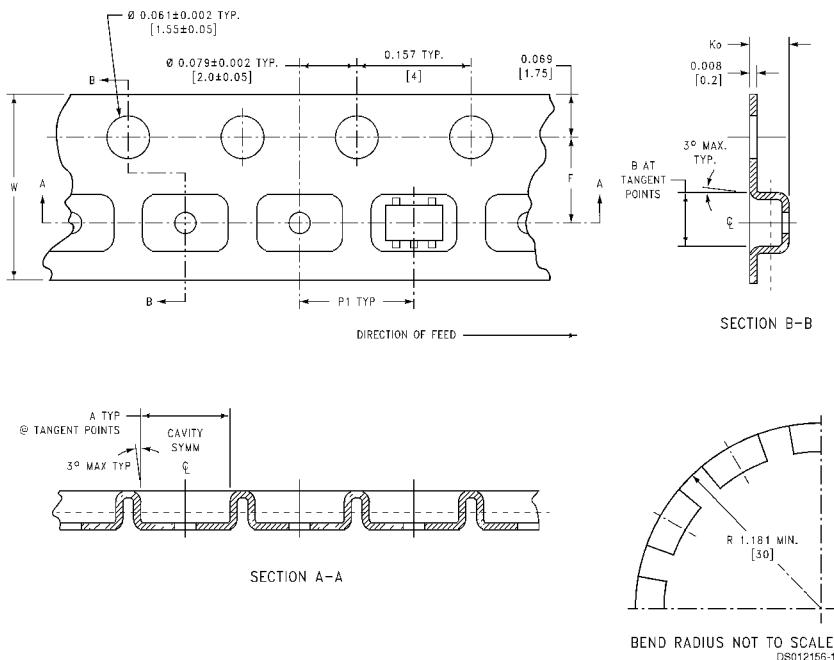
DS012156-6

Tape and Reel Specification

Tape Format

Package Designator	Tape Section	Number Cavities	Cavity Status	Cover Tape Status
M5, P5	Leader (Start End)	125 (typ)	Empty	Sealed
	Carrier	250	Filled	Sealed
	Trailer (Hub End)	75 (typ)	Empty	Sealed
M5X, P5X	Leader (Start End)	125 (typ)	Empty	Sealed
	Carrier	3000	Filled	Sealed
	Trailer (Hub End)	75 (typ)	Empty	Sealed

TAPE DIMENSIONS inches (millimeters)

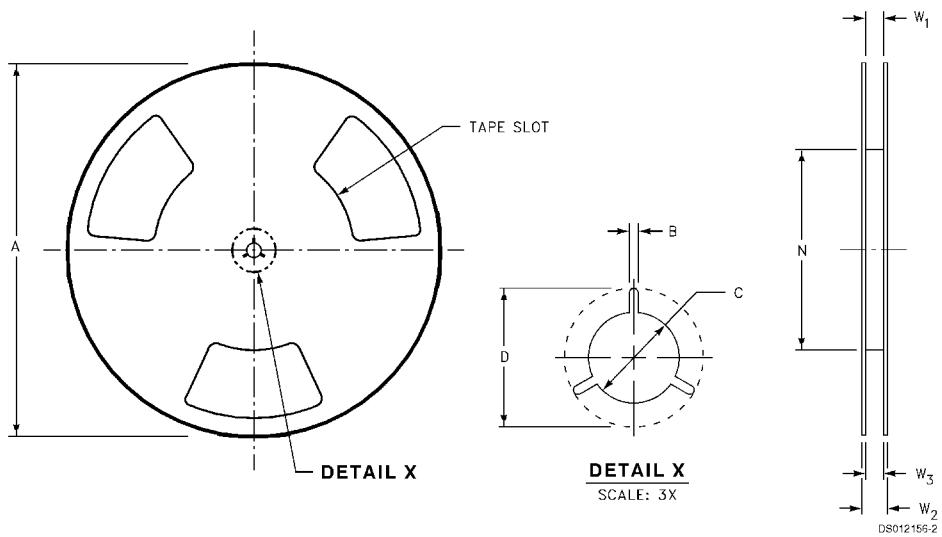


Pkg	Tape Size	DIM A	DIM B	DIM F	DIM K _o	DIM P1	DIM W
SC70-5	8 mm	0.093 (2.35)	0.096 (2.45)	0.138 ± 0.004 (3.5 ± 0.10)	0.053 ± 0.004 (1.35 ± 0.10)	0.157 (4)	0.315 ± 0.004 (8 ± 0.1)
SOT23-5	8 mm	0.130 (3.3)	0.130 (3.3)	0.138 ± 0.002 (3.5 ± 0.05)	0.055 ± 0.004 (1.4 ± 0.11)	0.157 (4)	0.315 ± 0.012 (8 ± 0.3)

Tape and Reel Specification

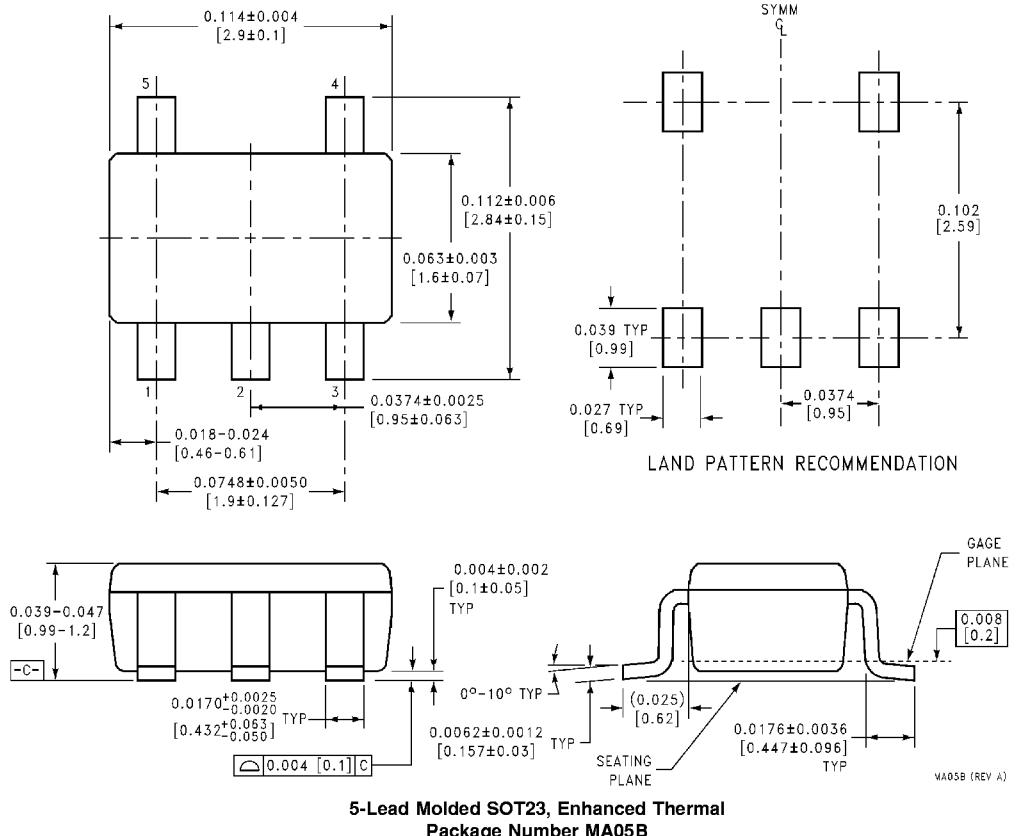
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REEL DIMENSIONS inches (millimeters)



Tape Size	A	B	C	D	N	W1	W2	W3
8 mm	7.0 (177.8)	0.059 (1.50)	0.512 (13.00)	0.795 (20.20)	2.165 (55.00)	0.331 +0.059/-0.000 (8.40 +1.50/-0.00)	0.567 (14.40)	W1 +0.078/-0.039 (W1 +2.00/-1.00)

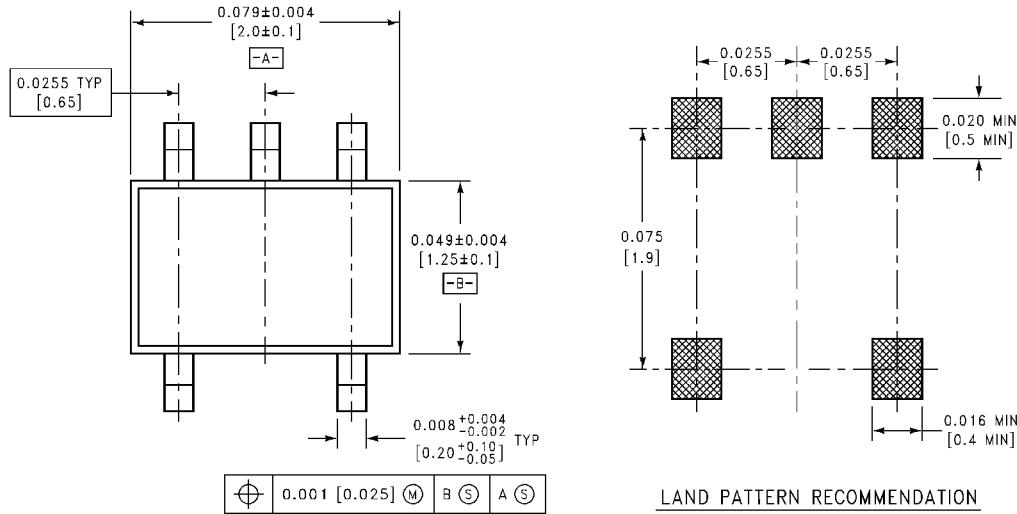
Physical Dimensions inches (millimeters) unless otherwise noted



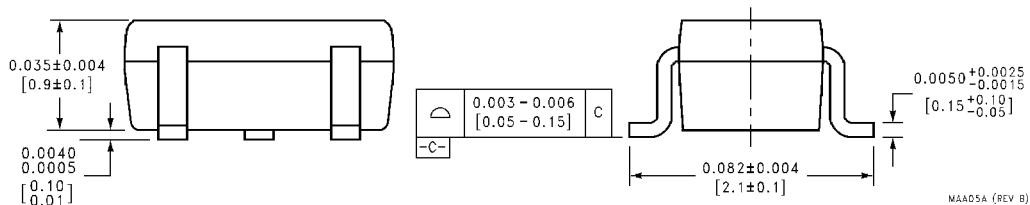
5-Lead Molded SOT23, Enhanced Thermal
Package Number MA05B

NC7SZ00 TinyLogic UHS 2-Input NAND Gate

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



LAND PATTERN RECOMMENDATION



**5-Lead Molded SC70, Enhanced Thermal
Package Number MAA05A**

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